Product Preview

Small Signal MOSFET

12 V, Complementary, 2.0 x 2.0 mm UDFN Package

Features

- Advanced Trench Complementary MOSFET
- Low RDS(on)
- Low Profile UDFN 2.0x2.0x0.55mm for Board Space Saving
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- Power Load Switch
- Load Switch with Level Shift
- Optimized for Power Management in Ultra Portable Devices

MAXIMUM RATINGS (T_J = 25°C unless otherwise specified)

Para	Symbol	Value	Unit			
Drain-to-Source Voltage	NMOS	\/	12	V		
Diam-to-Source voltag	PMOS	V_{DSS}	12	V		
Gate-to-Source Voltage	Onto to Onema Vallage			±8.0	V	
Gale-to-Source voltag	6	PMOS	V_{GS}	±8.0	"	
N-Channel	Steady	$T_A = 25^{\circ}C$		6.4		
Continuous Drain	State	$T_A = 85^{\circ}C$	I_{D}	4.6	Α	
Current (Note 1)	t ≤ 5 s	$T_A = 25^{\circ}C$		8.1		
P-Channel	Steady	$T_A = 25^{\circ}C$		-4.6		
Continuous Drain	State	$T_A = 85^{\circ}C$	I _D	-3.3	Α	
Current (Note 1)	t ≤ 5 s	$T_A = 25^{\circ}C$		-5.9		
Power Dissipation (Note 1)	Steady State	T _A = 25°C	P _D	1.40	W	
(Note 1)	t ≤ 5 s	$T_A = 25^{\circ}C$		2.29	W	
Pulsed Drain Current	NMOS	t = 10 us	lou	21	Α	
Fulsed Dialii Culterit	PMOS	t _p = 10 μs	I _{DM}	14	^	
Source Current (Body I	IS	1.6	Α			
Source Current (Body E		-1.6	ζ			
Operating Junction and	T _J , T _{STG}	–55 to 150	°C			
Lead Temperature for S from case for 10 s)	TL	260	°C			

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface—mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq), 1 oz. Cu.

This document contains information on a product under development. ON Semiconductor reserves the right to change or discontinue this product without notice.

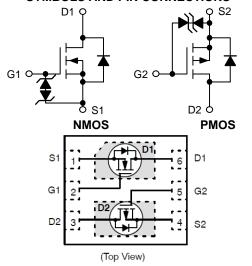


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V _{(BR)DSS}	R _{DS(on)} Max	I _D Max		
	23 mΩ @ 4.5 V	6.4 A		
N-Channel 12 V	26 mΩ @ 3.3 V			
	31 mΩ @ 2.5 V	0.4 A		
	59 mΩ @ 1.8 V			
	44 mΩ @ -4.5 V			
P-Channel -12 V	55 mΩ @ -3.3 V	-4.6 A		
	75 mΩ @ –2.5 V	- 4 .0 A		
	175 mΩ @ –1.8 V			

SYMBOLS AND PIN CONNECTIONS



MARKING DIAGRAM



UDFN6 CASE 527AD



AA = Specific Device Code M = Date Code

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTLUD3C20CZTAG	UDFN6	3000 / Tape &
NTLUD3C20CZTBG	(Pb-Free)	Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Ambient - Steady State, Minimum Pad (Note 1)	$R_{\theta JA}$	89.3	°C/W
Junction-to-Ambient – $t \le 5$ s (Note 1)		54.6	

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	FET	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS								
	.,	N	.,	I _D = 250 μA	12			
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	Р	$V_{GS} = 0 V$	I _D = -250 μA	-12			V
Drain-to-Source Breakdown Voltage	V _{(BR)DSS} /	N				TBD		
Temperature Coefficient	TJ	Р				TBD		mV/°C
		Ť.,	V _{GS} = 0 V, V _{DS} = 9.6 V	T _J = 25°C			1	μΑ
Zana Oata Walkana Dasia Oamaad		N		T _J = 125°C			10	
Zero Gate Voltage Drain Current	I _{DSS}	_	V 0VV 00V	T _J = 25°C			-1	
		P	$V_{GS} = 0 \text{ V}, V_{DS} = -9.6 \text{ V}$	T _J = 125°C			-10	μΑ
Cata to Causa Lashana Cumant	,	N	., ., .,				±100	^
Gate-to-Source Leakage Current	I _{GSS}	Р	$V_{DS} = 0 \text{ V}, V_{GS} =$	±8.0 V			±100	nA
ON CHARACTERISTICS (Note 2)								
Cata Throphold Voltage	V _{GS(TH)}	N	V _{GS} = V _{DS}	I _D = 250 μA	0.4		1.0	V
Gate Threshold Voltage		Р		$I_D = -250 \mu A$	-0.4		-1.0	
Negative Threshold Temperature	V _{GS(TH)} / T _J	N				TBD		mV/°C
Coefficient		Р				TBD		11117/ 0
	R _{DS(on)}	z	V _{GS} = 4.5 V	$I_D = 5 A$		18	23	mΩ
			$V_{GS} = 3.3 \text{ V}$	I _D = 5 A		21	26	
			V _{GS} = 2.5 V	$I_D = 4.6 A$		25	31	
Drain-to-Source On Resistance			V _{GS} = 1.8 V	I _D = 4 A		47	59	
Diam to Course of Resistance		Р	$V_{GS} = -4.5 \text{ V},$	$I_{D} = -4 \text{ A}$		35	44	
			$V_{GS} = -3.3 \text{ V}$	$I_{D} = -4 \text{ A}$		44	55	
			$V_{GS} = -2.5 \text{ V},$	$I_{D} = -3 \text{ A}$		60	75	
			V _{GS} = −1.8 V	I _D = -1 A		140	175	
Forward Transconductance	O=0	N	V _{DS} = 5 V	I _D = 5 A		TBD		S
Torward Transconductance	9FS	Р	$V_{DS} = -5 \text{ V}$ $I_D = -4 \text{ A}$			TBD		J
CAPACITANCES								
Input Capacitance	C _{ISS}		N $f = 1 \text{ MHz}, V_{GS} = 0 \text{ V}$ $V_{DS} = 9.6 \text{ V}$			1074		
Output Capacitance	C _{OSS}	N				147		pF
Reverse Capacitance	C _{RSS}					139		
Input Capacitance	C _{ISS}		P $f = 1 \text{ MHz}, V_{GS} = 0 \text{ V}$ $V_{DS} = -9.6 \text{ V}$			1201		ρı
Output Capacitance	C _{OSS}	Р				150		_
Reverse Capacitance	C _{RSS}					145		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

2. Switching characteristics are independent of operating junction temperatures

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

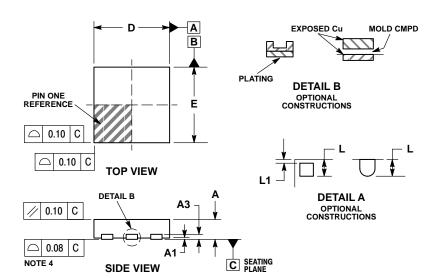
Parameter	Symbol	FET	Test Condition		Min	Тур	Max	Unit
CHARGES	•	•				•		
Total Gate Charge	Q _{G(TOT)}		$V_{GS} = 4.5 \text{ V}, V_{DS} = 9.6 \text{ V}, I_D = 5 \text{ A}$			10.8		
Threshold Gate Charge	Q _{G(TH)}	1				0.8		
Gate-to-Source Charge	Q _{GS}	N				1.9		
Gate-to-Drain Charge	Q_{GD}	1				2.4		
Total Gate Charge	Q _{G(TOT)}					12.6		nC
Threshold Gate Charge	Q _{G(TH)}	P	45777	C \		0.9		
Gate-to-Source Charge	Q _{GS}	7	$V_{GS} = -4.5 \text{ V}, V_{DS} = -9.0$	6 V, I _D = -4 A		1.7		
Gate-to-Drain Charge	Q_{GD}					2.8		
SWITCHING CHARACTERISTIC	S (Note 2)							
Turn-On Delay Time	t _{d(ON)}		$V_{GS} = 4.5 \text{ V}, V_{DS} = 9.6 \text{ V}, R_{G} = 1.0 \Omega$			7.6		
Rise Time	t _r	٦				22		
Turn-Off Delay Time	t _{d(OFF)}	N				22		
Fall Time	t _f	1				4.0		
Turn-On Delay Time	t _{d(ON)}		V_{GS} = -4.5 V, V_{DD} = -9.6 V, R_G = 1.0 Ω			6.8		ns
Rise Time	t _r	P				18		
Turn-Off Delay Time	t _{d(OFF)}	7 -				33		
Fall Time	t _f	1				9.9		
DRAIN-SOURCE DIODE CHARA	ACTERISTICS							
Forward Diode Voltage		N	$V_{GS} = 0 \text{ V, } I_{S} = 1.0 \text{ mA}$	T _J = 25°C		0.8	1.1	
				T _J = 125°C		TBD		
	V_{SD}			T _J = 25°C		-0.8	-1.1	V
		P	$V_{GS} = 0 \text{ V}, I_{S} = -1.0 \text{ mA}$	T _J = 125°C		TBD		

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2. Switching characteristics are independent of operating junction temperatures

PACKAGE DIMENSIONS

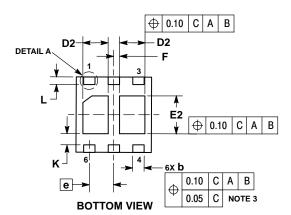
UDFN6 2x2, 0.65P CASE 517BF ISSUE B



NOTES

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: MILLIMETERS.
- 0.15 AND 0.30 mm FROM THE TERMINAL TIP.
 4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

TAD AS WELL AS THE TERM						
	MILLIMETERS					
DIM	MIN	MAX				
Α	0.45	0.55				
A1	0.00	0.05				
A3	0.13	REF				
b	0.25 0.35					
D	2.00 BSC					
D2	0.57 0.77					
E	2.00 BSC					
E2	0.90 1.10					
е	0.65 BSC					
F	0.15 BSC					
K	0.25 REF					
L	0.20 0.30					
L1	0.10					



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